

<b>Notice of References Cited</b>	Application/Control No. 10/587,917		Applicant(s)/Patent Under Reexamination VANDEVOORDE ET AL.	
	Examiner Louis K. Huynh		Art Unit 3721	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,551,258	12-1970	FARLEY LLOYD M; et. al.	53/291
*	B	US-4,102,728	07-1978	Smith, Donald C.	53/291
*	C	US-4,215,460	08-1980	Amberg et al.	53/292
*	D	US-4,243,466	01-1981	Lindee, Scott A.	53/585
*	E	US-4,519,186	05-1985	Winter et al.	53/585
*	F	US-5,060,367	10-1991	Vandevoorde, Jean-Claude	53/585
*	G	US-6,263,940	07-2001	Menayan, Victor V.	53/585
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.